

XPT IGBT Module

preliminary

$$V_{CES} = 1200V$$

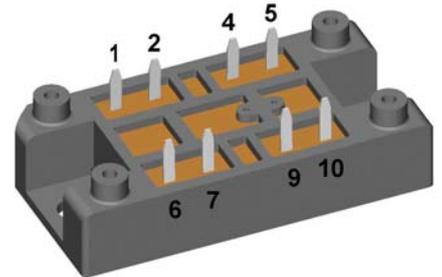
$$I_{C25} = 220A$$

$$V_{CE(sat)} = 1.8V$$

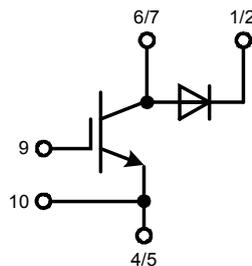
Boost Chopper

Part number

MIXA150R1200VA



Backside: isolated



Features / Advantages:

- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged XPT design (Xtreme light Punch Through) results in:
 - short circuit rated for 10 μ sec.
 - very low gate charge
 - low EMI
 - square RBSOA @ 3x I_c
- Thin wafer technology combined with the XPT design results in a competitive low $V_{CE(sat)}$
- SONIC™ diode
 - fast and soft reverse recovery
 - low operating forward voltage

Applications:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies
- Inductive heating, cookers
- Pumps, Fans

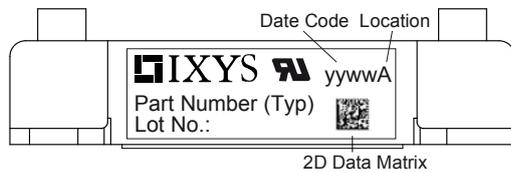
Package: V1-A-Pack

- Isolation Voltage: 3600 V~
- Industry standard outline
- RoHS compliant
- Soldering pins for PCB mounting
- Height: 17 mm
- Base plate: DCB ceramic
- Reduced weight
- Advanced power cycling

IGBT				Ratings			
Symbol	Definition	Conditions	min.	typ.	max.	Unit	
V_{CES}	collector emitter voltage	$T_{VJ} = 25^{\circ}\text{C}$			1200	V	
V_{GES}	max. DC gate voltage				± 20	V	
V_{GEM}	max. transient gate emitter voltage				± 30	V	
I_{C25}	collector current	$T_C = 25^{\circ}\text{C}$			220	A	
I_{C80}		$T_C = 80^{\circ}\text{C}$			150	A	
P_{tot}	total power dissipation	$T_C = 25^{\circ}\text{C}$			695	W	
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 150\text{A}; V_{GE} = 15\text{V}$		1.8	2.1	V	
				2.1		V	
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 6\text{mA}; V_{CE} = V_{CE}$	5.4	5.9	6.5	V	
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0\text{V}$			0.5	mA	
				1		mA	
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20\text{V}$			500	nA	
$Q_{G(on)}$	total gate charge	$V_{CE} = 600\text{V}; V_{GE} = 15\text{V}; I_C = 150\text{A}$		470		nC	
$t_{d(on)}$	turn-on delay time	inductive load $V_{CE} = 600\text{V}; I_C = 150\text{A}$ $V_{GE} = \pm 15\text{V}; R_G = 4.7\ \Omega$		70		ns	
t_r	current rise time		$T_{VJ} = 125^{\circ}\text{C}$	40		ns	
$t_{d(off)}$	turn-off delay time		250		ns		
t_f	current fall time		100		ns		
E_{on}	turn-on energy per pulse		14		mJ		
E_{off}	turn-off energy per pulse		16		mJ		
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15\text{V}; R_G = 4.7\ \Omega$					
I_{CM}		$V_{CEmax} = 1200\text{V}$			450	A	
SCSOA	short circuit safe operating area	$V_{CEmax} = 1200\text{V}$					
t_{sc}	short circuit duration	$V_{CE} = 900\text{V}; V_{GE} = \pm 15\text{V}$			10	μs	
I_{sc}	short circuit current	$R_G = 4.7\ \Omega; \text{non-repetitive}$		600		A	
R_{thJC}	thermal resistance junction to case				0.18	K/W	
R_{thCH}	thermal resistance case to heatsink			0.20		K/W	
Diode							
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^{\circ}\text{C}$			1200	V	
I_{F25}	forward current	$T_C = 25^{\circ}\text{C}$			190	A	
I_{F80}		$T_C = 80^{\circ}\text{C}$			130	A	
V_F	forward voltage	$I_F = 150\text{A}$			2.20	V	
				1.95		V	
I_R	reverse current	$V_R = V_{RRM}$			0.3	mA	
				0.8		mA	
Q_{rr}	reverse recovery charge	$V_R = 600\text{V}$ $-di_F/dt = 2500\text{A}/\mu\text{s}$ $I_F = 150\text{A}; V_{GE} = 0\text{V}$		20		μC	
I_{RM}	max. reverse recovery current		$T_{VJ} = 125^{\circ}\text{C}$	175		A	
t_{rr}	reverse recovery time		350		ns		
E_{rec}	reverse recovery energy		10		mJ		
R_{thJC}	thermal resistance junction to case				0.28	K/W	
R_{thCH}	thermal resistance case to heatsink			0.20		K/W	

preliminary

Package V1-A-Pack		Ratings				
Symbol	Definition	Conditions	min.	typ.	max.	Unit
I_{RMS}	RMS current	per terminal			100	A
T_{stg}	storage temperature		-40		125	°C
T_{VJ}	virtual junction temperature		-40		150	°C
Weight				37		g
M_D	mounting torque		2		2.5	Nm
$d_{Spp/App}$	creepage distance on surface striking distance through air	terminal to terminal	6.0			mm
$d_{Spb/Apb}$		terminal to backside	12.0			mm
V_{ISOL}	isolation voltage	t = 1 second	3600			V
		t = 1 minute	3000			V



Part number

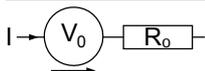
- M = Module
- I = IGBT
- X = XPT IGBT
- A = Gen 1 / std
- 150 = Current Rating [A]
- R = Boost Chopper
- 1200 = Reverse Voltage [V]
- VA = V1-A-Pack

Ordering	Part Number	Marking on Product	Delivery Mode	Quantity	Code No.
Standard	MIXA150R1200VA	MIXA150R1200VA	Box	10	511595

Equivalent Circuits for Simulation

* on die level

$T_{VJ} = 150^\circ\text{C}$

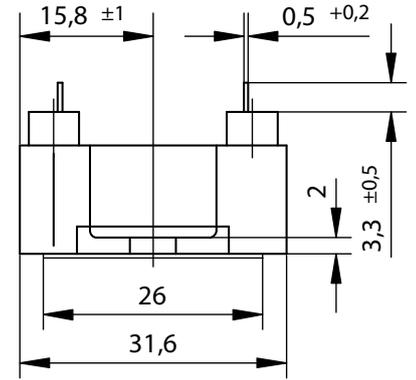
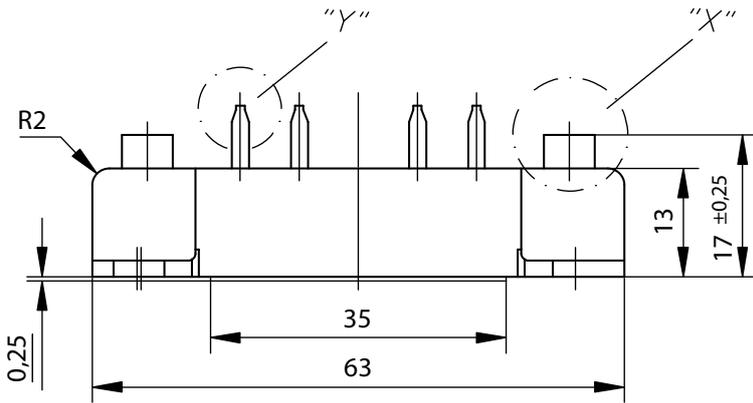


$V_{0\max}$ threshold voltage

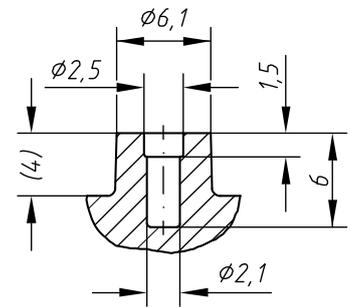
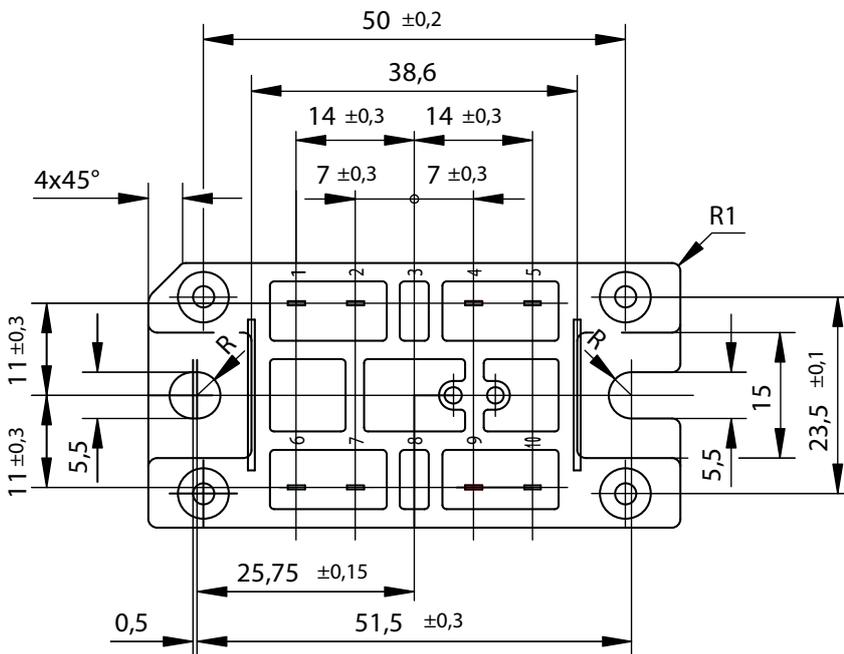
$R_{0\max}$ slope resistance *

	IGBT	Diode	
$V_{0\max}$	1.1	1.25	V
$R_{0\max}$	9.2	5.7	mΩ

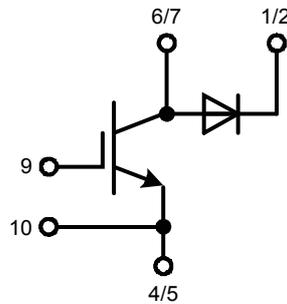
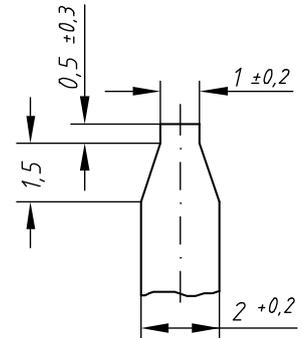
Outlines V1-A-Pack



Detail "X" M 2:1



Detail "Y" M 5:1



IGBT

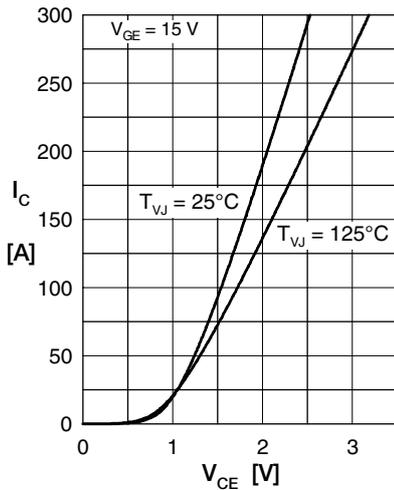


Fig. 1 Typ. output characteristics

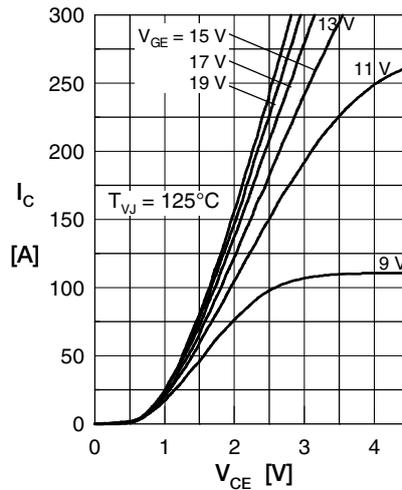


Fig. 2 Typ. output characteristics

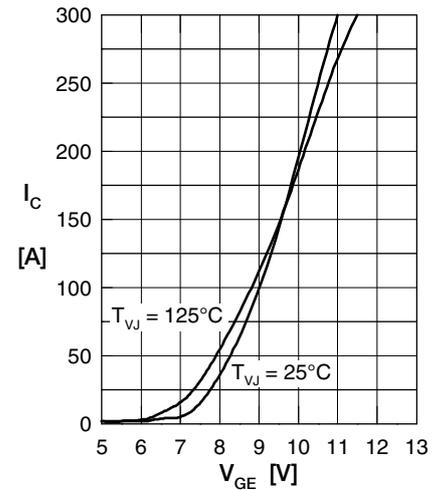


Fig. 3 Typ. transfer characteristics

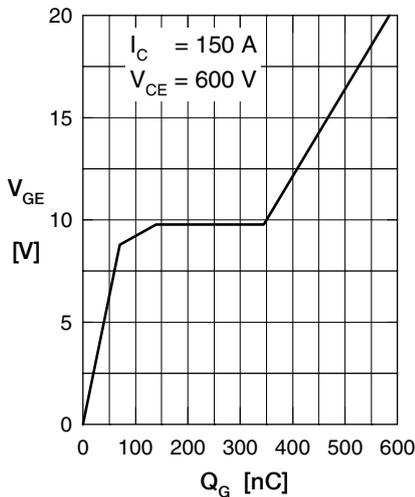


Fig. 4 Typ. turn-on gate charge

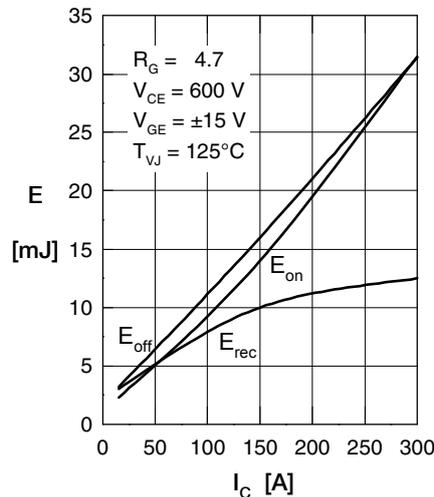


Fig. 5 Typ. switching energy versus collector current

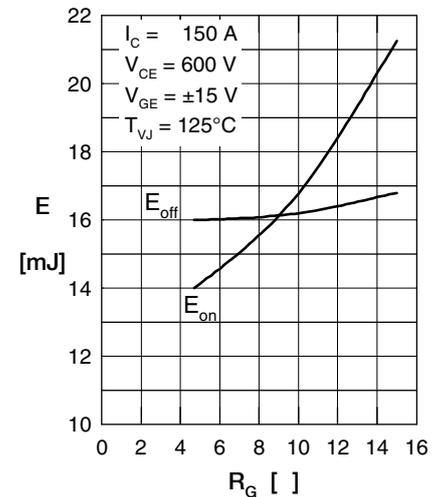


Fig. 6 Typ. switching energy versus gate resistance

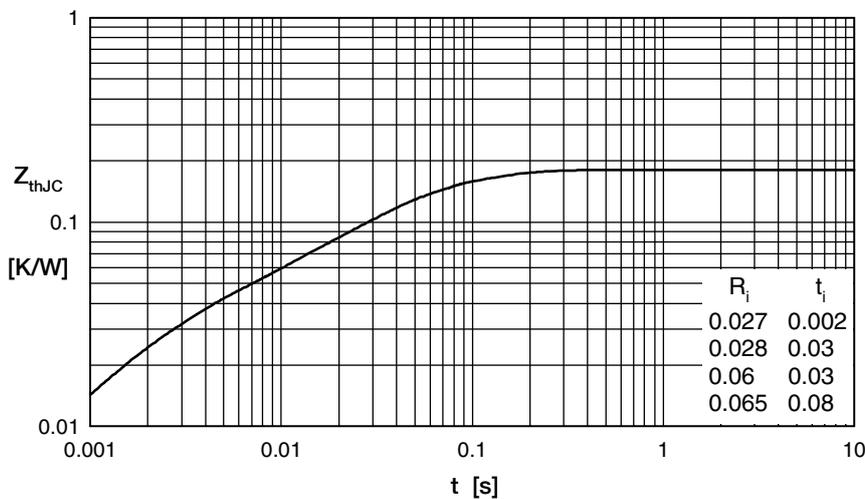


Fig. 7 Typ. transient thermal impedance

Diode

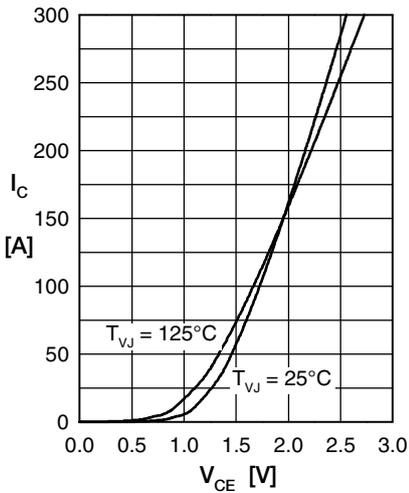


Fig. 1 Typ. Forward current versus V_F

Fig. 2 Typ. reverse recovery charge Q_{rr} versus di/dt

Fig. 3 Typ. peak reverse current I_{RM} versus di/dt

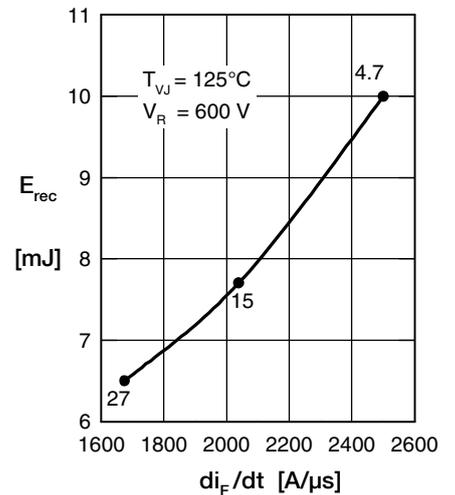


Fig. 4 Dynamic parameters Q_{rr} , I_{RM} versus T_{VJ}

Fig. 5 Typ. recovery time t_{rr} versus $-di_F/dt$

Fig. 6 Typ. recovery energy E_{rec} versus $-di/dt$

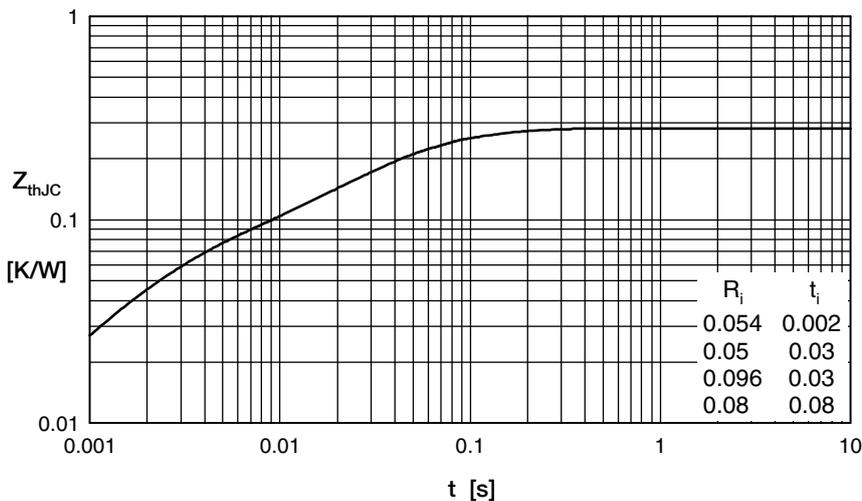


Fig. 7 Transient thermal impedance junction to case

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